Applicant(s)/Patent Under Application/Control No. Reexamination 10/617,076 TANAKA, GENICHI **Notice of References Cited** Examiner Art Unit Page 1 of 1 Sun J. Lin 2825 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY * 11-2002 Roethig et al. 716/6 US-6,487,705 B1 Α * 716/006 US-2004/0205683 A1 10-2004 Kovacs-Birkas et al. В US-С US-D US-Ε US-F US-G

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